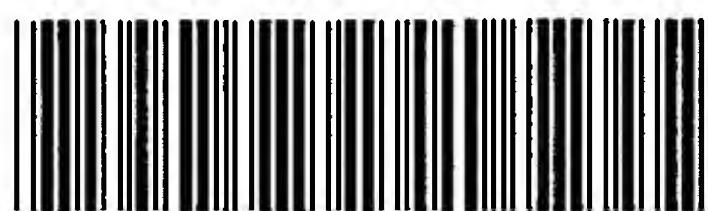


Search Notes**Application/Control No.**

10/711,671

Examiner

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Applicant(s)/Patent under Reexamination

CHIU, YAO-CHENG

Art Unit

2112

SEARCHED

Class	Subclass	Date	Examiner
710	305-306	6/21/2006	KH
710	100	6/21/2006	KH
711	103	6/21/2006	KH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search uspat; uspgpub; epo; jpo; derwent	6/21/2006	KH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner